

Search Notes



Application/Control No.

10/506,320

Examiner

Frederick L. Lagman

Applicant(s)/Patent under Reexamination

LEE, KEUN HEE

Art Unit

3673

SEARCHED

Class	Subclass	Date	Examiner
405	15		
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Eastman	6/10/02	R